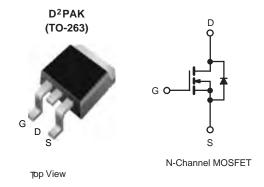


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N-Channel 200-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{(BR)DSS} (V)	$r_{DS(on)}(\Omega)$	I _D (A)			
200	0.035 at V _{GS} = 10 V	45			





APPLICATIONS

- LCD/LED TV
- Consumer Appliances

• 100 % R_{g} and UIS tested

• Low Thermal Resistance Package

- Lighting
- AC-DC Power Supply

ABSOLUTE MAXIMUM RATINGS (TC	= 25 °C, unl	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	200	V	
Gate-Source Voltage			V_{GS}	± 20	v	
Continuous Drain Current	V_{GS} at 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$		L	45 ^a		
Continuous Drain Current	VGS at 10 V	T _C = 100 °C	- I _D	30 ^a	Α	
Pulsed Drain Current			I _{DM}	180		
Single Pulse Avalanche Energy			E _{AS}	139	mJ	
Avalanche Current			I _{AR}	42	Α	
Repetiitive Avalanche Energy	E _{AR}	33	mJ			
Maximum Power Dissipation	T _C = 25 °C		P_D	203	W	
Maximum rower bissipation	T _A = 25 °C ^b			3.5 ^c		
Peak Diode Recovery dV/dt			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) for 10 s			Ü	300		

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient (PCB Mounted, Steady-State)	R _{thJA}	-	40	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.45			

- a. Package limited.
- b. When Mounted on 1" square PCB (FR-4 material).
- c. See SOA curve for voltage derating.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				1			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	200	-	-		
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	-	4	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
		V _{DS} = 160 V, V _{GS} = 0 V	-	-	1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 160 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 \text{ °C}$	-	-	100		
		$V_{DS} = 160 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 175 ^{\circ}\text{C}$	-	-	2	mA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	45	-	-	Α	
Drain-Source On-State Resistance a	R _{DS(on)}	V _{GS} = 10 V, I _D = 15 A	-	0.035	0.045	Ω	
Forward Transconductance a	9fs	V _{DS} = 20 V, I _D = 15 A	-	12	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	10050	-	pF	
Output Capacitance	Coss	$V_{GS} = 0 \text{ V}, V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}$	-	480	-		
Reverse Transfer Capacitance	C _{rss}		-	94	-		
Total Gate Charge ^c	Qg		-	93	-	nC	
Gate-Source Charge ^c	Q_{gs}	$V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$	-	22	-		
Gate-Drain Charge ^c	Q _{gd}		-	39	-		
Gate Resistance	R_g	f = 1 MHz	-	4.2	-	Ω	
Turn-On Delay Time c	t _{d(on)}		-	17	-		
Rise Time ^c	t _r	V_{DD} = 100 V, R_L = 1.67 Ω	=	25	-	20	
Turn-Off Delay Time ^c	t _{d(off)}	$I_D\cong$ 15 A, V_{GEN} = 10 V, R_g = 1 Ω	-	29	-	ns	
Fall Time ^c	t _f		1	11	-		
Drain-Source Body Diode Ratings ar	nd Characteris	stics ^b (T _C = 25 °C)		1			
Pulsed Current (t = 100 μs)	I _{SM}		-	-	180	Α	
Forward Voltage a	V _{SD}	I _F = 20 A, V _{GS} = 0 V	-	0.75	1.2	V	
Reverse Recovery Time	t _{rr}		-	88	-	ns	
Peak Reverse Recovery Charge	IRM(REC)	$I_F = 20 \text{ A}, \text{ d/dt} = 100 \text{ A/}\mu\text{s}$	-	5	-	Α	
Reverse Recovery Charge	Q _{rr}		-	0.25	-	μC	

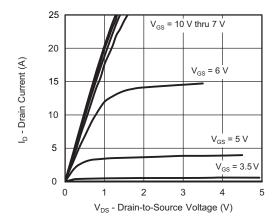
Notes

- a. Pulse test; pulse width $\leq\!300~\mu\text{s},$ duty cycle $\leq\!2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

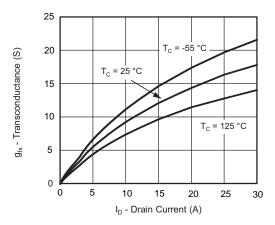
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



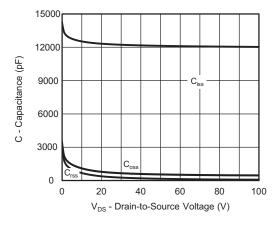
TYPICAL CHARACTERISTICS ($T_A = 25$ °C, unless otherwise noted)



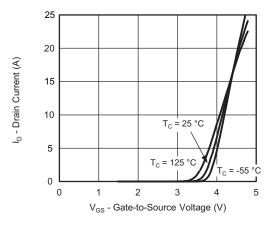
Output Characteristics



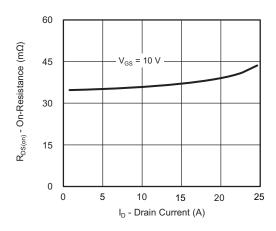
Transconductance



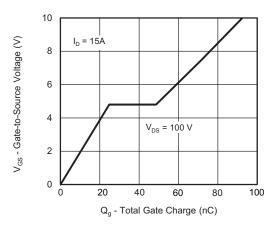
Capacitance



Transfer Characteristics



On-Resistance vs. Drain Current

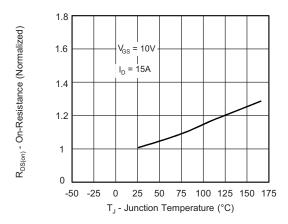


Gate Charge

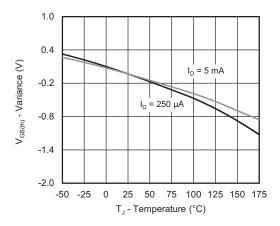


TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

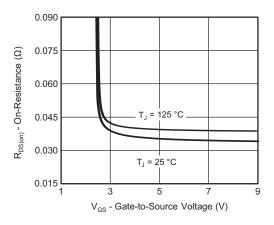




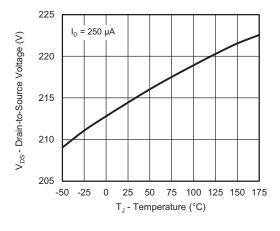
On-Resistance vs. Junction Temperature



Threshold Voltage



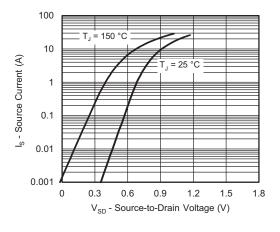
On-Resistance vs. Gate-to-Source Voltage



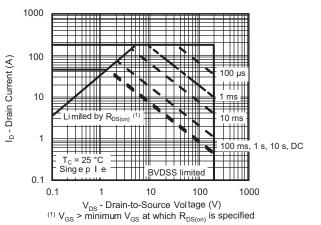
Drain Source Breakdown vs. Junction Temperature







Source Drain Diode Forward Voltage



Safe Operating Area



THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)

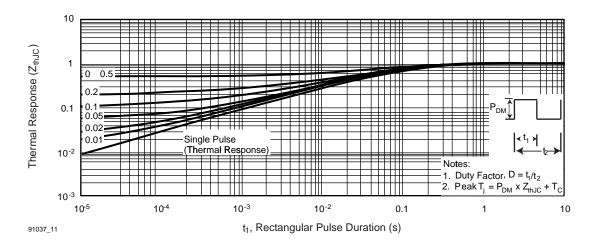
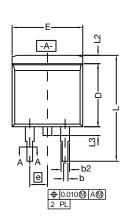
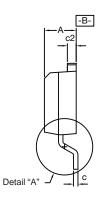


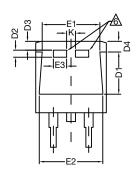
Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



TO-263 (D²PAK): 3-LEAD

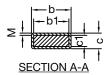








DETAIL A (ROTATED 90°)



10°,	: -][_	<u>∓</u>
1	L1	<u>T</u>

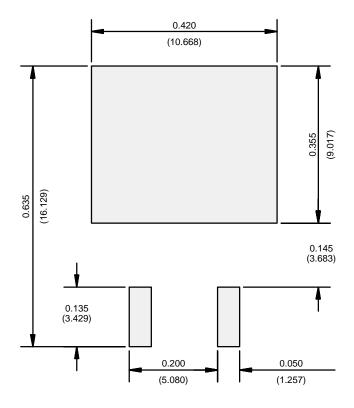
Notes

- 1. Plane B includes maximum features of heat sink tab and plastic.
- 2. No more than 25 % of L1 can fall above seating plane by max. 8 mils.
- 3. Pin-to-pin coplanarity max. 4 mils.
- 4. *: Thin lead is for SUB, SYB. Thick lead is for SUM, SYM, SQM.
- 5. Use inches as the primary measurement. This feature is for thick lead.

		INCHES		MILLIMETERS		
	DIM.	MIN.	MAX.	MIN.	MAX.	
Α		0.160	0.190	4.064	4.826	
	b	0.020	0.039	0.508	0.990	
	b1	0.020	0.035	0.508	0.889	
	b2	0.045	0.055	1.143	1.397	
c*	Thin lead	0.013	0.018	0.330	0.457	
	Thick lead	0.023	0.028	0.584	0.711	
c1	Thin lead	0.013	0.017	0.330	0.431	
CI	Thick lead	0.023	0.027	0.584	0.685	
	c2	0.045	0.055	1.143	1.397	
	D	0.340	0.380	8.636	9.652	
	D1	0.220	0.240	5.588	6.096	
	D2	0.038	0.042	0.965	1.067	
	D3	0.045	0.055	1.143	1.397	
	D4	0.044	0.052	1.118	1.321	
	Е	0.380	0.410	9.652	10.414	
	E1	0.245	=	6.223	=	
	E2	0.355	0.375	9.017	9.525	
	E3	0.072	0.078	1.829	1.981	
	е	0.100	BSC	2.54 BSC		
	K	0.045	0.055	1.143	1.397	
	L	0.575	0.625	14.605	15.875	
L1		0.090	0.110	2.286	2.794	
L2		0.040	0.055	1.016	1.397	
L3		0.050	0.070	1.270	1.778	
L4		0.010 BSC		0.254 BSC		
	М	-	0.002	-	0.050	
ECN: T13-0707-Rev. K, 30-Sep-13						

DWG: 5843

RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)





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